

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 58546.00013	SERIAL NO. New Div. Appln.
LIST OF REFERENCES CITED BY APPLICANT  (Use several sheets if necessary)		APPLICANT NISHIO <span style="float: right;">10/766481</span>	
		FILING DATE January 29, 2004	GROUP 1722


## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
<i>JA</i>	AA	5,645,868	07-1997	Reinhart, William A.	425	145	
	AB	5,679,384	10-1997	Emoto, Atsushi	425	145	
	AC	5,891,485	04-1999	Emoto, Atsushi	425	145	
	AD	5,911,924	06-1999	Siegrist et al	264	40.1	
	AE	6,394,780	05-2002	Hehl, Karl	425	145	
	AF	6,517,336	02-2003	Emoto et al	425	145	
	AG	6,051,896	04-2000	Shibuya et al			
<i>JA</i>	AH	5,823,293	10-1998	Gilbertson et al			

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION		
							YES	NO	PART.
<i>JA</i>	AI	EP 1 004 421 A1	05-2000	Europe	—	—			
	AJ	DE 299 10 332 U1	11-2000	Germany				X	
	AK	JP 2000-71304 A	03-2000	Japan					Ab
	AL	DE 198 52 513 A1	06-1999	Germany				X	
	AM	DE 200 21 187 U1	04-2001	Germany				X	
	AN	JP 5-220796 A	08-1993	Japan					Ab
	AO	JP 5-77295 A	03-1993	Japan					Ab
	AP	JP 2000-52393 A	02-2000	Japan					Ab
	AQ	JP 2000-52395 A	02-2000	Japan					Ab
	AR	05345337	12-1993	Japan (Abstract)					Ab
	AS	11320602	11-1999	Japan (Abstract)					Ab
	AT	DE 195 48 756 A1	06-1997	Germany				X	
	AU	JP 2000-52394	02-2000	Japan					Ab
<i>JA</i>	AV	JP 11-291311	10-1999	Japan					Ab

**OTHER REFERENCES** (Including Author, Title, Date, Pertinent Pages, Etc.)

	AW	
	AX	
	AY	
EXAMINER:		DATE CONSIDERED 3/18/06
<b>*EXAMINER:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		